IAP20 Rec'd PCT/PTO 23 JUN 2006

XA-10578

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE In re the Application of:

FUKUDA, Keiko et al.

Intl. Appln. No.: PCT/JP2004/017910

Intl. Filing Date: 2 December 2004

For: VOLTAGE GENERATION CIRCUIT AND SEMICONDUCTOR

INTEGRATED CIRCUIT DEVICE

PRELIMINARY AMENDMENT

Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

Attn: Mail Stop PCT, DO/EO/US

Sir:

Prior to examination, please amend the aboveidentified patent application as indicated below.

Amendments to the claims are reflected in the listing of claims which begin on page 2 of this paper.

Remarks begin on page 13 of this paper.